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Fault-tolerant numerical iterative algorithms at scale

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Introduction

Initially: We have an iterative algorithm (i.e., an initialization and then a repeated code, one repetition is an iteration) that is executed on a large-scale platform.

Issue: Errors of different types can strike during the execution.

Aim: Protect the execution of the iterative algorithm in an optimized way (better in terms of cost than to check for error at each iteration).

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We consider different types of errors:

- Fail-stop error: When it strikes, the system crashes (immediately)
- Silent error: If not corrected, Wrong output. Two different types:
 - Computation error: For a + b, the output is c' instead of c (a + b = c)
 - Memory error: Bit-flip in memory (affects static data)

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Mitigation techniques

• Fail-stop error: Global checkpoint



• Silent error: Local checkpoint and verifications:



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Aim of this work

Protect the iterative algorithm against errors:

- A model with verifications, checkpoints and rollbacks
- Not specific to an iterative algorithm
- But easy to optimize and to execute

Hence:

- The model is a periodic pattern (easy to implement and not bound to the iterative algorithm)
- Optimize the expected time of the pattern

Often, when we protect an iterative algorithm, verifications and checkpoints (at least for silent errors) are done at each iteration of the algorithm. We consider this approach as the naive approach.



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 $T_{calc} = n_{vc}I + V_c$ $T_{mem} = n_{cm}(T_{calc}) + V_m$ $T_{fs} = n_{fs}(T_{mem} + C_{cm})$ *n_{vc}*: number of iteration in a chunk *n_{cm}*: number of chunks *n_{fs}*: number of segments

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Hypotheses			

We need some hypotheses to create the model:

- All the iterations have the same size
- Recall and precision of verification is 1 (no false positive or negative)
- No silent error strikes during checkpoint and verification
- No fail-stop error strikes during the fail-stop checkpoint



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Expected time of the pattern

Expected time of the pattern

Let *E* be the expected time of the pattern, it depends on n_{fs} , n_{cm} , n_{vc} (resp. number of iterations in a chunk, number of chunks, number of segments in the pattern).

Useful work in the pattern (execution of the iterative algorithm): $W = n_{fs}n_{cm}n_{vc}I$.

Goal: find expected time E and then minimize the overhead

$$\min \frac{E(n_{fs}, n_{cm}, n_{vc})}{n_{fs}n_{cm}n_{vc}I}$$



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Expected time of the pattern

Computation of the expected time



$$E = \sum_{k=0}^{n_{fs}-1} E_k + C_{fs}$$

 E_k is the expected time of the *k*th segment



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Expected time of the pattern

Expected time of the segment

Case 1: No errors



 $\Rightarrow P_{succ}^{fs,mem,calc}[T_{mem} + C_{cm}]$



Case 2: The first error to be detected is a memory error



- No computation error strikes during the execution of the segment (otherwise it would have been detected)
- No fail-stop error strikes during the execution of the segment(it would have been detected)

$$\Rightarrow P_{fail}^{mem} P_{succ}^{calc} P_{succ}^{fs} [T_{mem} + R_{cm} + E_k]$$



Case 3: The first error to be detected is a computation error



- No fail-stop error strikes before the computation error is detected
- Memory errors can strike (the memory verification is after the computation ones)

$$\Rightarrow \sum_{i=1}^{n_{cm}} P_{fail}^{calc}(i) P_{succ}^{fs}(i) [iT_{calc} + R_{cm} + E_k]$$



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Expected time of the pattern

Expected time of the segment

Case 4: The first error to be detected is a fail-stop error



- No computation error strikes in the previous chunks
- Memory errors can strike

$$\Rightarrow (1 - P_{no_{fs}})[E_{lost} + R_{fs} + \sum_{i=0}^{k} E_i]$$



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Expected time of the pattern

The formula for the mean time

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$$E = \sum_{k=0}^{n_{fs}-1} E_k + C_{fs}$$
$$E = \frac{M}{1 - P_{no_fs}} \left[\left(\frac{1 - P_{no_fs}}{P_{succ}^{fs,mem,calc}} + 1 \right)^{n_{fs}} - 1 \right] + C_{fs}$$

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Expected time of the pattern

Minimization ...

$$\begin{split} M &= e^{-(n_{cm}(T_{calc})+V_m)(\lambda_{l5}+\lambda_{mem})-C_{cm}\lambda_{l5}}(f_{calc})^{n_{vc}n_{cm}}[n_{cm}(T_{calc})+V_m+C_{cm}] \\ &+ (1-e^{-\lambda_{mem}(n_{cm}(T_{calc})+V_m)}) e^{-\lambda_{l5}(n_{cm}(T_{calc})+V_m)}(f_{calc})^{n_{vc}n_{cm}}[n_{cm}(T_{calc})+V_m+R_{cm}] \\ &+ (1-f_{calc}^{n_{vc}}) e^{-\lambda_{l5}}T_{calc} \left(\frac{(f_{calc}^{n_{vc}}e^{-\lambda_{l5}}T_{calc})^{n_{cm}}-1}{f_{calc}^{n_{vc}}e^{-\lambda_{l5}}T_{calc}-1} \right) [R_{cm}] \\ &+ (1-f_{calc}^{n_{vc}}) e^{-\lambda_{l5}}T_{calc} \left(\frac{(f_{calc}^{n_{vc}}e^{-\lambda_{l5}}T_{calc})^{n_{cm}}-1}{(f_{calc}^{n_{vc}}e^{-\lambda_{l5}}T_{calc}-1)} \right) [(n_{vc}I+V_c)] \\ &+ (1-f_{calc}^{n_{vc}}) e^{-\lambda_{l5}}T_{calc} \left(\frac{(f_{calc}^{n_{vc}}e^{-\lambda_{l5}}T_{calc})^{n_{cm}}(n_{cm}(f_{calc}^{n_{vc}}e^{-\lambda_{l5}}T_{calc}-1)-1)+1}{(f_{calc}^{n_{vc}}e^{-\lambda_{l5}}T_{calc}-1)^2} \right) [(n_{vc}I+V_c)] \\ &+ [1-[e^{-(n_{cm}(T_{calc})+V_m)(\lambda_{l5}+\lambda_{mem})-C_{cm}\lambda_{l5}}(f_{calc})^{n_{vc}n_{cm}}} \\ &+ (1-e^{-\lambda_{mem}(n_{cm}(T_{calc})+V_m)}) e^{-\lambda_{l5}(n_{cm}(T_{calc})+V_m)}(f_{calc})^{n_{vc}n_{cm}} \\ &+ (1-f_{calc}^{n_{vc}}) e^{-\lambda_{l5}}T_{calc} \left(\frac{(f_{calc}^{n_{vc}}e^{-\lambda_{l5}}T_{calc})^{n_{cm}}-1}{f_{calc}^{n_{vc}}e^{-\lambda_{l5}}T_{calc}-1} \right)]] [\frac{1}{\lambda_{l5}} - \frac{n_{cm}(T_{calc})+V_m+C_{cm}}}{e^{\lambda_{l5}(n_{cm}(T_{calc})+V_m+C_{cm}}-1} + R_{l5}] \end{split}$$

ightarrow Difficult to minimize analytically ... (and this only for an exponential distribution)

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Preconditioned Conjugated Gradient (PCG)

For the simulation, we choose the Preconditioned Conjugated Gradient (PCG) for the iterative algorithm. PCG was the main motivation for this work.

PCG solves a system of linear equations when the matrix is positive semi-definite:

Ax = b

We use it because there are previous works to protect PCG from silent errors¹ (the contents of the V_c verification).

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Simulation setting

- The simulation depends on the probabilities of errors: the variable x
- Error distributions: exponential distribution. Mean time between faults $(MTBF = \frac{1}{\lambda})$:
 - MTBF(fail-stop error) = x (between 1h and 8h)
 - MTBF(memory error) = $\frac{x}{2}$
 - MTBF(computation error) $=\frac{x}{20}$
- For the checkpoints, the whole state is stored in the fail-stop checkpoint, whereas the memory checkpoint stores only the updated variables
- The memory verification is done through checksums

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Scenarios: extrapolations from data

Scenario	Scenario 2 ²	Scenario 3 ³
Size of the problem	$3.6 imes10^{12}$	$1.1 imes10^{13}$
Number of nodes	$3 imes 10^3$	$2 imes 10^4$
1	13	110
V _c	2	17
V _m	6	3
C _{cm}	0.5	0.25
R _{cm}	0.5	0.25
C _{fs}	180	540
R _{fs}	180	540
	second	second

²N. Kohl and U. Rüde, "Textbook efficiency: Massively parallel matrix-free multigrid for the stokes system," 2022

 3 M. Mohr, U. Rüde, B. Wohlmuth, and H.-P. Bunge, "Challenges for Mantle Convection Simulations at the ExaScale: Numerics, Algorithmics and Software", 2023

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Simulation results: Scenario 2



For x=4 hours, (3,2,22) corresponds to n_{vc} =3 iterations in a chunk, n_{cm} =2 chunks in a segment and n_{fs} =22 segments in a pattern Overhead $min \frac{E(4hours, 3,2,22)}{I \times 3 \times 2 \times 22}$: approximately 1.5 compared to the naive approach E(4hours, 1, 1, 1) which is 15

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Simulation results: Scenario 3



This scenario's result resembles the naive approach. This happens because the cost of a fail-stop checkpoint is massive and the cost of one iteration really exceeds the other costs.

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Contributions:

- New model considering three types of failures in numerical iterative applications
- Computation of expected time
- Instantiation of the model on various realistic scenarios and simulations: Better than naive approach in terms of expected time

Future works: Some hypotheses are classical in the literature but not really realistic. Is it possible to remove these hypotheses? For instance, what if the recall or precision of verification is not 1, what are the consequence on the model and expected time?